Page 1 of 2 Applicant(s) Application No. PTO-1449 William R. Zoltan, et al. 10/042,034 **Information Disclosure Citation** Filing Date Docket No. Group Art Unit Ein an Application 10/19/01 069312.0111 RECEIVED **U.S. PATENT DOCUMENTS** FEB 0 4 2002 FEB 2 6 2002 DOCUMENT NO. DATE **CLASS SUBCLASS NAME** Technology Center 2100 A TRAD 5,822,531 10/13/98 . 395 - -200.51 7/22/96 Gorczyca et al. 8/23/96 В 5,918,017 6/29/99 Attanasio et al. 395--200.54C _709 229 12/9/96 5,938,732 8/17/99 Lim et al. --249---4/24/97 D Ogle et al. 709-5,983,281 11/9/99 Е 11/16/99 Duso et al. 714 5/5/97 5,987,621 4--4---10/14/97 5,996,086 11/30/99 Delaney et al. 714-F G 6,003,075 12/14/99 Arendt et al. 709-221__ 7/7/97 Н 6,006,259 12/21/99 Adelman et al. -709 -223-11/20/98

FOREIGN PATENT DOCUMENTS

Bartfai et al.

Colyer

Narendran et al.

Yu

Adelman et al.

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
N							
0							***
P							
Q				,, ,			
R							

	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
 S		
T		
U		

EXAMINER

I

J

K

L

M

6,012,150

6,023,722

6,070,191

6,078,943

6,078,957

1/4/00

2/8/00

5/30/00

6/20/00

6/20/00

DATE CONSIDERED

1/28/04

714

709---

709---

709_

709

4

201

-226

105

224

3/27/97

7/23/97

10/17/97

2/7/97

11/20/98

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

U.S. PATENT AND TRADEMARK OFFICE

Application No. Applicant(s) PTO-1449 10/042,034 William R. Zoltan, et al. **Information Disclosure Citation** Filing Date 10/19/01 Docket No. Group Art Unit In an Application 069312.0111

FEB 0 4 2002

U.S. PATENT DOCUMENTS

A~ .	DOS MENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DAT
X	6,078,960	6/20/00	Ballard	-709_	_229_	7/3/98
В	6,088,727	7/11/00	Hosokawa et al.	709_	-223-	10/17/97
С	6,101,508	8/8/00	Wolff	707-	_218	4/15/98
D	6,119,143	9/12/00	Dias et al.	709	-201-	5/22/97
E	6,128,279	10/3/00	O'Neil et al.	370	229	10/1/98
F	6,128,644	10/3/00	Nozaki	709 .	203	7/20/98
G	6,151,688	11/21/00	Wipfel et al.	714	48	2/14/98
Н	6,175,869	1/16/01	Ahuja et al.	709	-226	4/8/98
I	6,178,160	1/23/01	Bolton et al.	370	255	12/23/97
J	6,182,139	1/30/01	Brendel	709	226-	6/23/98
K	6,185,601	2/6/01	Wolff	709	-203-	4/15/98
L	6,185,619	2/6/01	Joffe et al.	709	229-	11/7/97
M	6,185,695	2/6/01	Murphy et al.	-7:14-	_4	4/9/98

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
N			nrc	EIVED			
0							
P				2 6 2002			
Q			Technolog	y Center 2100			
R							

		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
	S		
	Т		
(Tay	U	/ 4	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

U.S. PATENT AND TRADEMARK OFFICE

